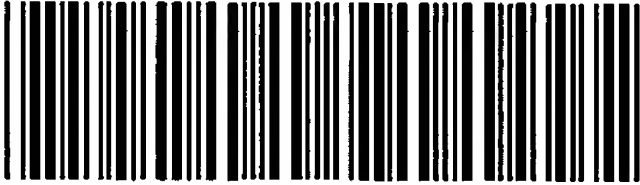


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/667,668	FUKUDA ET AL.	
	Examiner	Art Unit	
	Erin D. Chiem	2883	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PLUS search	9/16/2005	EDC
Inventorship search	9/16/2005	EDC
text search and forward and backward citations	9/16/2005	edc